SN74ALS841, SN74AS841A, SN74ALS842 10-BIT BUS-INTERFACE D-TYPE LATCHES WITH 3-STATE OUTPUTS

SDAS059C - DECEMBER 1983 - REVISED JANUARY 1995

- 3-State Buffer-Type Outputs Drive Bus Lines Directly
- Bus-Structured Pinout
- Provide Extra Bus-Driving Latches Necessary for Wider Address/Data Paths or Buses With Parity
- Buffered Control Inputs to Reduce dc Loading Effects
- Power-Up High-Impedance State
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (NT) 300-mil DIPs

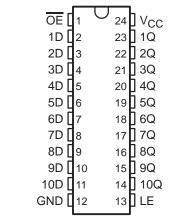
description

These 10-bit latches feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

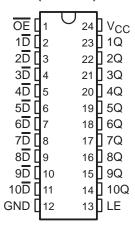
The ten latches are transparent D-type latches. The SN74ALS841 and SN74AS841A have noninverting data (D) inputs. The SN74ALS842 has inverting \overline{D} inputs.

A buffered output-enable (\overline{OE}) input places the ten outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

SN74ALS841, SN74AS841A . . . DW OR NT PACKAGE (TOP VIEW)



SN74ALS842 . . . DW OR NT PACKAGE (TOP VIEW)



OE does not affect the internal operation of the latches. Previously stored data can be retained or new data can be entered while the outputs are off.

The SN74ALS841, SN74AS841A, and SN74ALS842 are characterized for operation from 0°C to 70°C.

Function Tables

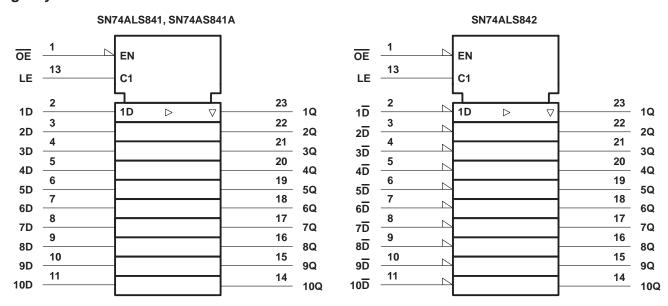
SN74ALS841, SN74AS841A

	INPUTS		OUTPUT
OE	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	Χ	Q ₀
Н	X	Χ	Z

SN74ALS842

	INPUTS		OUTPUT
OE	LE	D	Q
L	Н	Н	L
L	Н	L	н
L	L	Χ	Q ₀
Н	X	Χ	Z

logic symbols†



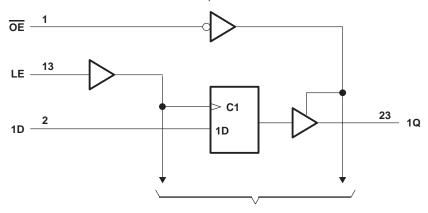
[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



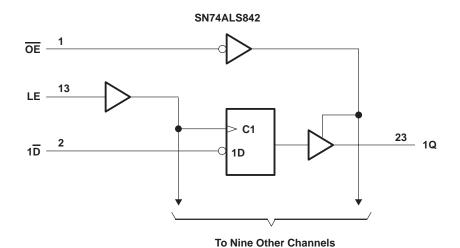
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logic diagrams (positive logic)

SN74ALS841, SN74AS841A



To Nine Other Channels



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 \/
Input voltage, V _I	
Voltage applied to a disabled 3-state output	
Operating free-air temperature range, T _A : SN74ALS841, SN74ALS842	
Storage temperature range –	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

SN74ALS841, SN74AS841A, SN74ALS842 10-BIT BUS-INTERFACE D-TYPE LATCHES WITH 3-STATE OUTPUTS

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recommended operating conditions

		SN74ALS841 SN74ALS842		UNIT	
		MIN	NOM	MAX	
Vcc	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
IOH	High-level output current			-2.6	mA
loL	Low-level output current			24	mA
t _W	Pulse duration, LE high	20			ns
t _{su}	Setup time, data before LE↓	10			ns
t _h	Hold time, data after LE↓	5			ns
T _A	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			SN74ALS841 SN74ALS842		
				MIN	TYP [†]	MAX	UNIT
VIK		V _{CC} = 4.5 V,	I _I = -18 mA			-1.2	V
V		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2			V
VOH		$V_{CC} = 4.5 V,$	$I_{OH} = -2.6 \text{ mA}$	2.4	3.2		V
M = .		V 45V	I _{OL} = 12 mA		0.25	0.4	V
VOL		$V_{CC} = 4.5 \text{ V}$ $I_{OL} = 24 \text{ mA}$ $V_{CC} = 5.5 \text{ V}$ $V_{CC} = 2.7 \text{ V}$		0.5	V		
lozh		V _{CC} = 5.5 V,	V _O = 2.7 V			20	μΑ
lozL		V _{CC} = 5.5 V,	V _O = 0.4 V			-20	μΑ
II		V _{CC} = 5.5 V,	V _I = 7 V			0.1	mA
lіН		V _{CC} = 5.5 V,	V _I = 2.7 V			20	μΑ
Ι _Ι L		V _{CC} = 5.5 V,	V _I = 0.4 V			-0.1	mA
lo [‡]		V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	mA
			Outputs high		19	30	
	SN74ALS841	V _{CC} = 5.5 V	Outputs low		38	62	
	SN74ALS842 V _{CC} = 5.5 V		Outputs disabled		23	40	4
ICC			Outputs high		20	35	mA
		$V_{CC} = 5.5 V$	Outputs low		48	74	
			Outputs disabled		27	44	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, $R1$ = 500 Ω , $R2$ = 500 Ω , T_A = MIN to MAX [†] SN74ALS841		UNIT
			MIN	MAX	1
^t PLH	- D	•	2	13	ns
t _{PHL}		Q	2	13	115
^t PLH	LE		7	21	ns
^t PHL	LE	Q	8	26	115
^t PZH	ŌĒ	•	2	12	
tPZL		Q	2	12	ns
t _{PHZ}	ŌĒ	Q	2	10	
^t PLZ	OE .	y	2	12	ns

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_A = MIN to MAX†		UNIT
4			MIN	MAX	\vdash
^t PLH	D	Q	4	18	ns
^t PHL		Q	3	13	
^t PLH	LE		8	27	ns
^t PHL	LL	Q	6	20	115
^t PZH			2	12	
t _{PZL}	ŌĒ	Q	2	12	ns
^t PHZ	ŌĒ	0	1	10	ns
^t PLZ)E	Q	2	12	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T _A : SN74AS841A	0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



SN74ALS841, SN74AS841A, SN74ALS842 10-BIT BUS-INTERFACE D-TYPE LATCHES WITH 3-STATE OUTPUTS

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recommended operating conditions

		SN	SN74AS841A		LINUT
		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			0.8	V
IOH	High-level output current			-24	mA
lOL	Low-level output current			48	mA
t _W	Pulse duration, LE high	4			ns
t _{su}	Setup time, data before LE↓	2.5			ns
t _h	Hold time, data after LE↓	2.5			ns
TA	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDI	TEST CONDITIONS		SN74AS841A		
PARAMETER	TEST CONDI			TYP†	MAX	UNIT
V _{IK}	$V_{CC} = 4.5 V,$	$I_{I} = -18 \text{ mA}$			-1.2	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2	2		
VOH	V _{CC} = 4.5 V	$I_{OH} = -15 \text{ mA}$	2.4	3.2		V
	VCC = 4.5 V	$I_{OH} = -24 \text{ mA}$	2			
V _{OL}	$V_{CC} = 4.5 V,$	$I_{OL} = 48 \text{ mA}$		0.35	0.5	V
lоzн	$V_{CC} = 5.5 V,$	$V_0 = 2.7 \text{ V}$			50	μΑ
lozL	$V_{CC} = 5.5 V,$	$V_0 = 0.4 \text{ V}$			-50	μΑ
ΙĮ	$V_{CC} = 5.5 V,$	V _I = 7 V			0.1	mA
liн	$V_{CC} = 5.5 V,$	V _I = 2.7 V			20	μΑ
Ι _{ΙL}	$V_{CC} = 5.5 V,$	V _I = 0.4 V			-0.5	mA
1 ₀ ‡	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	mA
		Outputs high		36	60	
Icc	V _{CC} = 5.5 V	Outputs low		58	94	mA
		Outputs disabled		56	93	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



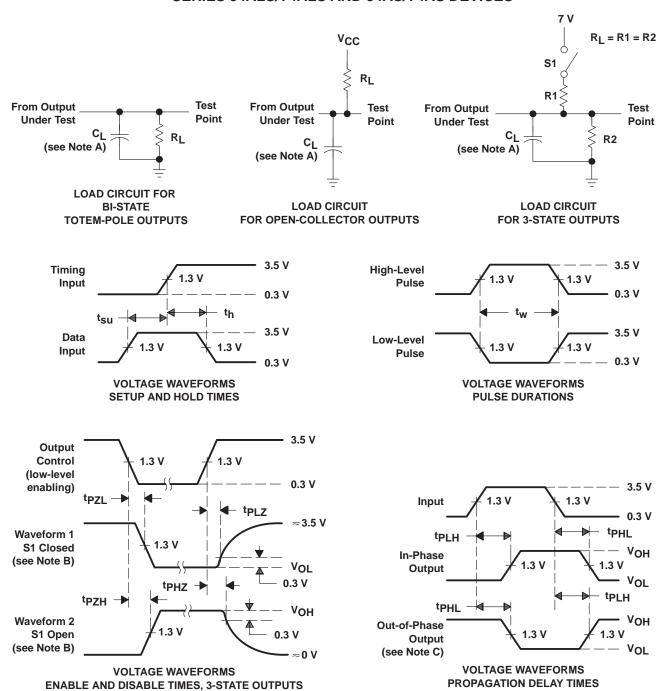
[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$\begin{array}{c} \text{V}_{\text{CC}} = 4.5 \text{ V to } 5.5 \text{ V,} \\ \text{C}_{\text{L}} = 50 \text{ pF,} \\ \text{R1} = 500 \ \Omega, \\ \text{R2} = 500 \ \Omega, \\ \text{T}_{\text{A}} = \text{MIN to MAX}^{\dagger} \\ \text{SN74AS841A} \end{array}$		UNIT
			MIN	MAX	
t _{PLH}	_ D	0	1	6.5	ns
^t PHL		Q	1	10.5	115
^t PLH	LE		2	12	ns
^t PHL	LE	Q	2	12	115
^t PZH			2	14	
tPZL	ŌĒ	Q	2	16	ns
^t PHZ	ŌĒ	0	1	8	
t _{PLZ}) DE	Q	1	8	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- All input pulses have the following characteristics: PRR \leq 1 MHz, $t_{\Gamma} = t_{f} = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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